## **TOSHIBA PHOTOCOUPLER**

# TLP620(D4)SERIES, TLP621(D4)SERIES, TLP750(D4)SERIES

ATTACHMENT: SPECIFICATIONS FOR VDE0884 OPTION: (D4)

 $Types: TLP620, \ TLP620-2, \ TLP620-3, \ TLP620-4, \ TLP621, \ TLP621-2, \ TLP621-3, \ TLP621-4, \ TLP750, \ TLP620-4, \ TLP$ 

**TLP751** 

Type designations for 'Option: (D4)', which are tested under VDE0884 requirements.

Ex. : TLP621 (D4-GR-LF2) D4 : VDE0884 option

GR: CTR rank

LF2: standard lead bend

Note : Use Toshiba standard type number for safety standard application.

Ex. TLP621 (D4-GR-LF2)  $\rightarrow$  TLP621

# **VDE0884 ISOLATION CHARACTERISTICS**

DESCRIPTION	SYMBOL	RATING	UNIT
Application Classification (DIN VDE0109/12.83, Table 1)			
for rated mains voltage $\leq 300  m V_{rms}$		I-IV	_
for rated mains voltage≦600V <sub>rms</sub>		I-III	
Climatic Classification		55/100/21	
(DIN IEC68 Teil 1/09.80)		35/100/21	
Pollution Degree (DIN VDE0109/12.83)		2	_
Maximum Operating Insulation Voltage	V <sub>IORM</sub>	890	Vpk
Input to output Test Voltage, Method A			
Vpr=1.5×V <sub>IORM</sub> , Type and Sample Test	Vpr	1335	Vpk
tp=60s, Partial Discharge<5pC			
Input to output Test Voltage, Method B			
$Vpr = 1.875 \times V_{IORM}$ , 100% Production Test	Vpr	1670	Vpk
tp=1s, Partial Discharge<5pC			
Highest Permissible Overvoltage	Van	8000	0 Vpk
(Transient Overvoltage, t <sub>pr</sub> =10s)	$V_{ m TR}$	3000	
Safety Limiting Values (Max. permissible ratings in			
case of fault, also refer to thermal derating curve)			
Current (Input current I <sub>F</sub> , $P_{si} = 0$ )	$I_{si}$	300	mA
Power (Output or Total Power Dissipation)	$P_{si}$	500	mW
Temperature	$\mathrm{T_{si}}$	150	°C
Insulation Resistance at Tsi, V <sub>IO</sub> =500V	R <sub>si</sub>	$\geqq$ $10^{9}$	Ω

1 2001-06-01

## INSULATION RELATED SPECIFICATIONS

Minimum Creepage Distance (*)	Cr	6.4mm	
Minimum Clearance (*)	Cl	6.4mm	
Minimum Insulation Thickness	ti	0.4mm	
Comperative Tracking Index	CTI	175	
(DIN IEC112/VDE0303, Part 1)	CII	(VDE0109/12.83 Group <b>I</b> I a)	

- ((\*) in accordance with DIN VDE0109/12.83, Table 2, & 4)
  - (\*1) If a printed circuit is incorporated, the creepage distance and clearance may be reduced below this value (e. g. at a standard distance between soldering eye centres of 7.5mm). If this is not permissible, the user shall take suitable measures.
  - (\*2) This photocoupler is suitable for 'safe electrical isolation' only within the safety limit data.

Maintenance of the safety data shall be ensured by means of protective circuits.

TLP620, 620-2, 620-3, 620-4 TLP621, 621-2, 621-3, 621-4

TLP750, 751

VDE Test sign: Marking on product

for VDE0884

4



Marking on packing for VDE0884

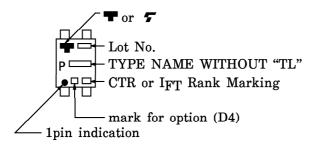


0884



0884

Marking Example: 4 pin Type



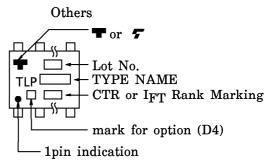


Figure 1 Partial discharge measurement procedure according to VDE0884 Destructive test for qualification and sampling tests.

## Method A

(for type and sampling tests, destructive tests)

$$t_1, t_2$$
 = 1 to 10s  
 $t_3, t_4$  = 1s  
 $t_1$  (Measuring time for  
partial discharge) = 50s  
 $t_2$  = 62s  
 $t_3$  = 10s

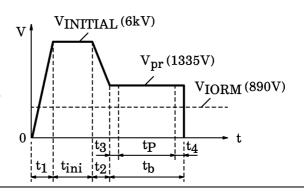


Figure 2 Partial discharge measurement procedure according to VDE0884 Non-destructive test for 100% inspection.

# Method B

(for sample test, non-destructive test)

$$t_3$$
,  $t_4$  = 0.1s  
 $t_p$  (Measuring time for  
partial discharge) = 1s  
 $t_b$  = 1.2s

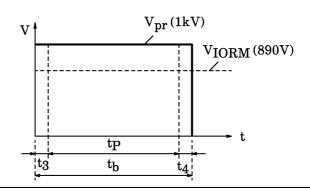


Figure 3 Dependency of maximum safety ratings on ambient temperature 1000 - I<sub>si</sub> (mA)  $\uparrow P_{si}$ (mW) 800 400 300 600 200 400  $I_{si} \leftarrow$ 100 200  $P_{si}$ 0 0 0 25 50 75 100 125 150 175 Ta (°C)

3 2001-06-01

## RESTRICTIONS ON PRODUCT USE

000707EBC

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- Gallium arsenide (GaAs) is a substance used in the products described in this document. GaAs dust and fumes are toxic. Do not break, cut or pulverize the product, or use chemicals to dissolve them. When disposing of the products, follow the appropriate regulations. Do not dispose of the products with other industrial waste or with domestic garbage.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- ◆ The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

4 2001-06-01